

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/616,266	IKAWA ET AL.	
Examiner	Art Unit	
Tawfik Goma	2627	

Tawfik Goma

	SEAR	SEARCHED		
Class	Subclass	Date	Examiner	
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INT	NTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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	arch (see ched)			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM_TDB) see attached search history	5/15/2006	TG		
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